

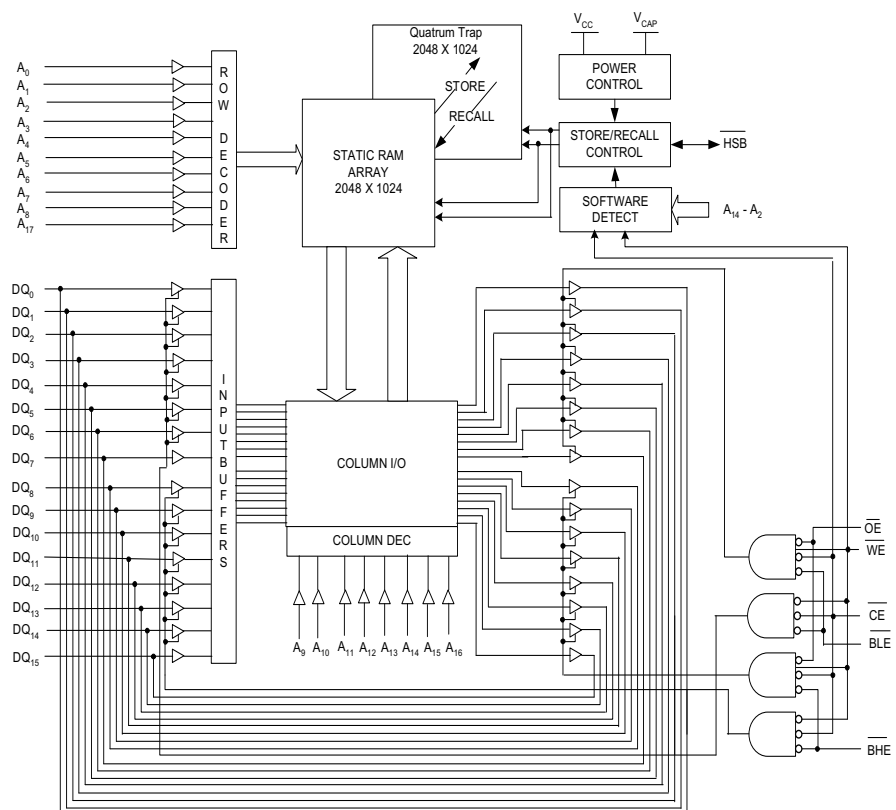
**Features**

- 20 ns, 25 ns, and 45 ns Access Times
- Internally organized as 256K x 8 (CY14B102L) or 128K x 16 (CY14B102N)
- Hands off Automatic STORE on power down with only a small Capacitor
- STORE to QuantumTrap® nonvolatile elements initiated by software, device pin, or AutoStore® on power down
- RECALL to SRAM initiated by software or power up
- Infinite Read, Write, and Recall Cycles
- 200,000 STORE cycles to QuantumTrap
- 20 year data retention
- Single 3V +20% to -10% operation
- Commercial, Industrial and Automotive Temperatures
- 48-ball FBGA and 44/54-pin TSOP - II packages
- Pb-free and RoHS compliance

**Functional Description**

The Cypress CY14B102L/CY14B102N is a fast static RAM, with a nonvolatile element in each memory cell. The memory is organized as 256K bytes of 8 bits each or 128K words of 16 bits each. The embedded nonvolatile elements incorporate QuantumTrap technology, producing the world's most reliable nonvolatile memory. The SRAM provides infinite read and write cycles, while independent nonvolatile data resides in the highly reliable QuantumTrap cell. Data transfers from the SRAM to the nonvolatile elements (the STORE operation) takes place automatically at power down. On power up, data is restored to the SRAM (the RECALL operation) from the nonvolatile memory. Both the STORE and RECALL operations are also available under software control.

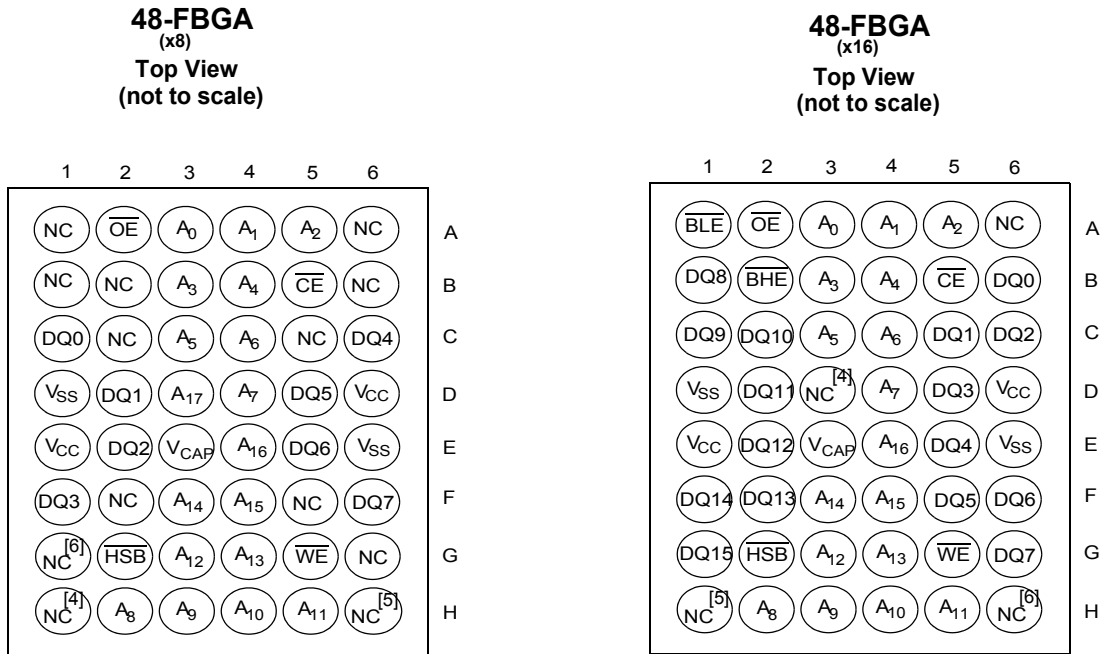
**Logic Block Diagram<sup>[1, 2, 3]</sup>**



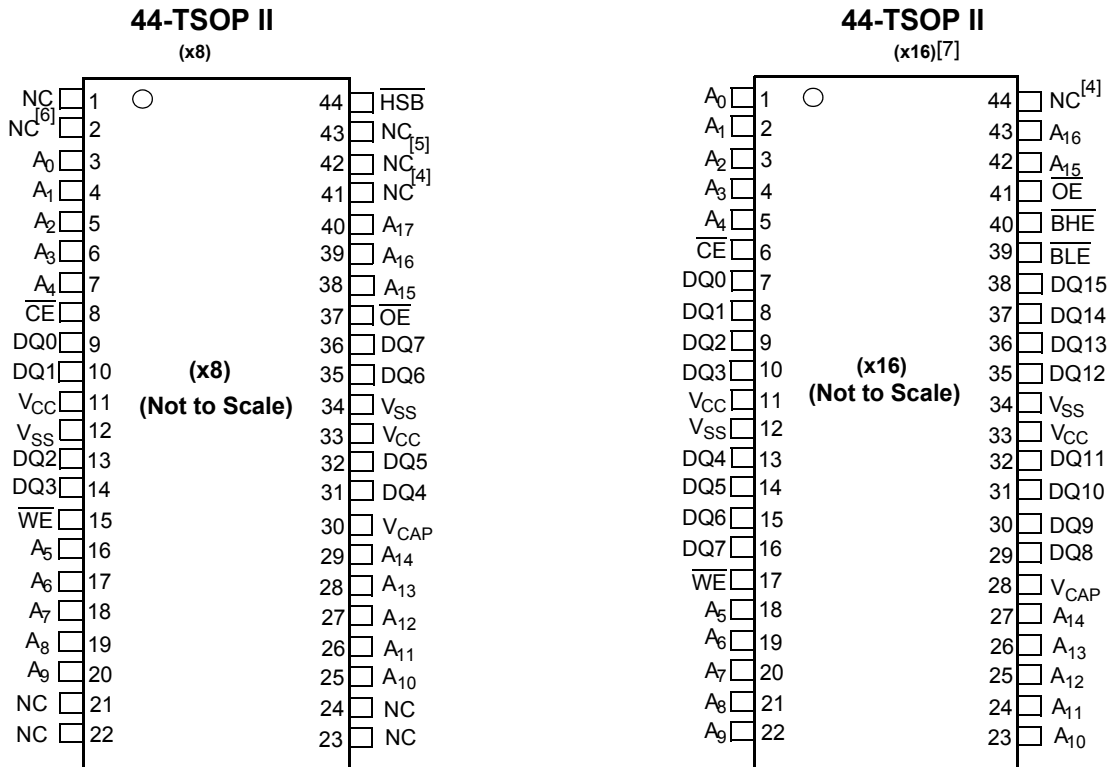
- Note**
1. Address A<sub>0</sub> - A<sub>17</sub> for x8 configuration and Address A<sub>0</sub> - A<sub>16</sub> for x16 configuration.
  2. Data DQ<sub>0</sub> - DQ<sub>7</sub> for x8 configuration and Data DQ<sub>0</sub> - DQ<sub>15</sub> for x16 configuration.
  3. BHE and BLE are applicable for x16 configuration only.

**Pinouts**

**Figure 1. Pin Diagram - 48 FBGA**



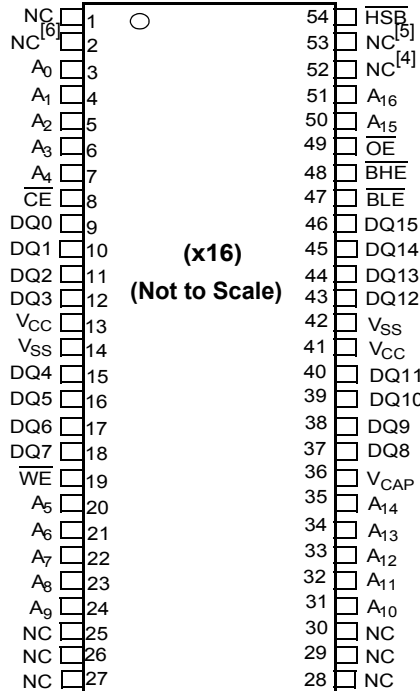
**Figure 2. Pin Diagram - 44 Pin TSOP II**



- Notes**
4. Address expansion for 4 Mbit. NC pin not connected to die.
  5. Address expansion for 8 Mbit. NC pin not connected to die.
  6. Address expansion for 16 Mbit. NC pin not connected to die.
  7. HSB pin is not available in 44-TSOP II (x16) package.

**Pinouts** (continued)

**Figure 3. Pin Diagram - 54 Pin TSOP II (x16)**



**Pin Definitions**

Pin Name	IO Type	Description
A <sub>0</sub> – A <sub>17</sub>	Input	<b>Address Inputs Used to Select one of the 262,144 bytes of the nvSRAM for x8 Configuration.</b>
A <sub>0</sub> – A <sub>16</sub>		<b>Address Inputs Used to Select one of the 131,072 words of the nvSRAM for x16 Configuration.</b>
DQ <sub>0</sub> – DQ <sub>7</sub>	Input/Output	<b>Bidirectional Data IO Lines for x8 Configuration.</b> Used as input or output lines depending on operation.
DQ <sub>0</sub> – DQ <sub>15</sub>		<b>Bidirectional Data IO Lines for x16 Configuration.</b> Used as input or output lines depending on operation.
$\overline{WE}$	Input	<b>Write Enable Input, Active LOW.</b> When selected LOW, data on the IO pins is written to the specific address location.
$\overline{CE}$	Input	<b>Chip Enable Input, Active LOW.</b> When LOW, selects the chip. When HIGH, deselects the chip.
$\overline{OE}$	Input	<b>Output Enable, Active LOW.</b> The active LOW $\overline{OE}$ input enables the data output buffers during read cycles. IO pins are tri-stated on deasserting $\overline{OE}$ HIGH.
$\overline{BHE}$	Input	<b>Byte High Enable, Active LOW.</b> Controls DQ <sub>15</sub> - DQ <sub>8</sub> .
$\overline{BLE}$	Input	<b>Byte Low Enable, Active LOW.</b> Controls DQ <sub>7</sub> - DQ <sub>0</sub> .
V <sub>SS</sub>	Ground	<b>Ground for the Device.</b> Must be connected to the ground of the system.
V <sub>CC</sub>	Power Supply	<b>Power Supply Inputs to the Device.</b>
$\overline{HSB}^{[7]}$	Input/Output	<b>Hardware Store Busy (HSB).</b> When LOW this output indicates that a hardware store is in progress. When pulled LOW external to the chip it initiates a nonvolatile STORE operation. A weak internal pull up resistor keeps this pin HIGH if not connected (connection optional). After each store operation HSB will be driven HIGH for short time with standard output high current.
V <sub>CAP</sub>	Power Supply	<b>AutoStore Capacitor.</b> Supplies power to the nvSRAM during power loss to store data from SRAM to nonvolatile elements.
NC	No Connect	<b>No Connect.</b> This pin is not connected to the die.

## Device Operation

The CY14B102L/CY14B102N nvSRAM is made up of two functional components paired in the same physical cell. They are an SRAM memory cell and a nonvolatile QuantumTrap cell. The SRAM memory cell operates as a standard fast static RAM. Data in the SRAM is transferred to the nonvolatile cell (the STORE operation), or from the nonvolatile cell to the SRAM (the RECALL operation). Using this unique architecture, all cells are stored and recalled in parallel. During the STORE and RECALL operations, SRAM read and write operations are inhibited. The CY14B102L/CY14B102N supports infinite reads and writes similar to a typical SRAM. In addition, it provides infinite RECALL operations from the nonvolatile cells and up to 200K STORE operations. See the “[Truth Table For SRAM Operations](#)” on page 15 for a complete description of read and write modes.

## SRAM Read

The CY14B102L/CY14B102N performs a read cycle when  $\overline{CE}$  and  $\overline{OE}$  are LOW and  $\overline{WE}$  and  $\overline{HSB}$  are HIGH. The address specified on pins  $A_{0-17}$  or  $A_{0-16}$  determines which of the 262,144 data bytes or 131,072 words of 16 bits each are accessed. Byte enables ( $\overline{BHE}$ ,  $\overline{BLE}$ ) determine which bytes are enabled to the output, in the case of 16-bit words. When the read is initiated by an address transition, the outputs are valid after a delay of  $t_{AA}$  (read cycle 1). If the read is initiated by  $\overline{CE}$  or  $\overline{OE}$ , the outputs are valid at  $t_{ACE}$  or at  $t_{DOE}$ , whichever is later (read cycle 2). The data output repeatedly responds to address changes within the  $t_{AA}$  access time without the need for transitions on any control input pins. This remains valid until another address change or until  $\overline{CE}$  or  $\overline{OE}$  is brought HIGH, or  $\overline{WE}$  or  $\overline{HSB}$  is brought LOW.

## SRAM Write

A write cycle is performed when  $\overline{CE}$  and  $\overline{WE}$  are LOW and  $\overline{HSB}$  is HIGH. The address inputs must be stable before entering the write cycle and must remain stable until  $\overline{CE}$  or  $\overline{WE}$  goes HIGH at the end of the cycle. The data on the common IO pins  $DQ_{0-15}$  are written into the memory if the data is valid  $t_{SD}$  before the end of a  $\overline{WE}$  controlled write or before the end of an  $\overline{CE}$  controlled write. The Byte Enable inputs ( $\overline{BHE}$ ,  $\overline{BLE}$ ) determine which bytes are written, in the case of 16-bit words. It is recommended that  $\overline{OE}$  be kept HIGH during the entire write cycle to avoid data bus contention on common IO lines. If  $\overline{OE}$  is left LOW, internal circuitry turns off the output buffers  $t_{HZWE}$  after  $\overline{WE}$  goes LOW.

## AutoStore Operation

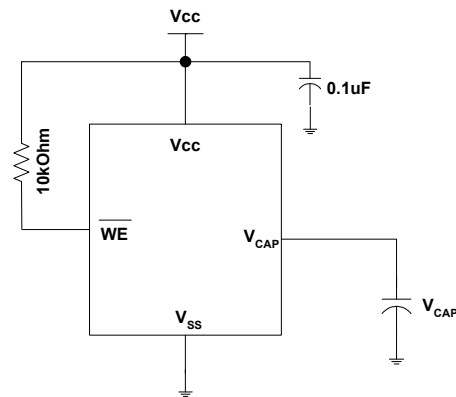
The CY14B102L/CY14B102N stores data to the nvSRAM using one of the following three storage operations: Hardware Store activated by  $\overline{HSB}$ ; Software Store activated by an address sequence; AutoStore on device power down. The AutoStore operation is a unique feature of QuantumTrap technology and is enabled by default on the CY14B102L/CY14B102N.

During a normal operation, the device draws current from  $V_{CC}$  to charge a capacitor connected to the  $V_{CAP}$  pin. This stored charge is used by the chip to perform a single STORE operation. If the voltage on the  $V_{CC}$  pin drops below  $V_{SWITCH}$ , the part automatically disconnects the  $V_{CAP}$  pin from  $V_{CC}$ . A STORE operation is initiated with power provided by the  $V_{CAP}$  capacitor.

Figure 4 shows the proper connection of the storage capacitor ( $V_{CAP}$ ) for automatic store operation. Refer to [DC Electrical Characteristics](#) on page 7 for the size of  $V_{CAP}$ . The voltage on the  $V_{CAP}$  pin is driven to  $V_{CC}$  by a regulator on the chip. A pull up should be placed on  $\overline{WE}$  to hold it inactive during power up. This pull up is only effective if the  $\overline{WE}$  signal is tri-state during power up. Many MPUs tri-state their controls on power up. This should be verified when using the pull up. When the nvSRAM comes out of power-on-recall, the MPU must be active or the  $\overline{WE}$  held inactive until the MPU comes out of reset.

To reduce unnecessary nonvolatile stores, AutoStore and hardware store operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. Software initiated STORE cycles are performed regardless of whether a write operation has taken place. The  $\overline{HSB}$  signal is monitored by the system to detect if an AutoStore cycle is in progress.

Figure 4. AutoStore Mode



## Hardware STORE Operation

The CY14B102L/CY14B102N provides the  $\overline{HSB}^{[7]}$  pin to control and acknowledge the STORE operations. Use the  $\overline{HSB}$  pin to request a hardware STORE cycle. When the  $\overline{HSB}$  pin is driven LOW, the CY14B102L/CY14B102N conditionally initiates a STORE operation after  $t_{DELAY}$ . An actual STORE cycle only begins if a write to the SRAM has taken place since the last STORE or RECALL cycle. The  $\overline{HSB}$  pin also acts as an open drain driver that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

SRAM read and write operations that are in progress when  $\overline{HSB}$  is driven LOW by any means are given time to complete before the STORE operation is initiated. After  $\overline{HSB}$  goes LOW, the CY14B102L/CY14B102N continues SRAM operations for  $t_{DELAY}$ . If a write is in progress when  $\overline{HSB}$  is pulled LOW it is enabled a time,  $t_{DELAY}$  to complete. However, any SRAM write cycles requested after  $\overline{HSB}$  goes LOW are inhibited until  $\overline{HSB}$  returns HIGH. In case the write latch is not set,  $\overline{HSB}$  will not be driven LOW by the CY14B102L/CY14B102N but any SRAM read and write cycles are inhibited until  $\overline{HSB}$  is returned HIGH by MPU or other external source.

During any STORE operation, regardless of how it is initiated, the CY14B102L/CY14B102N continues to drive the  $\overline{HSB}$  pin LOW, releasing it only when the STORE is complete. Upon

completion of the STORE operation, the CY14B102L/CY14B102N remains disabled until the HSB pin returns HIGH. Leave the HSB unconnected if it is not used.

**Hardware RECALL (Power Up)**

During power up or after any low power condition ( $V_{CC} < V_{SWITCH}$ ), an internal RECALL request is latched. When  $V_{CC}$  again exceeds the sense voltage of  $V_{SWITCH}$ , a RECALL cycle is automatically initiated and takes  $t_{HRECALL}$  to complete. During this time, HSB will be driven LOW by the HSB driver.

**Software STORE**

Transfer data from the SRAM to the nonvolatile memory with a software address sequence. The CY14B102L/CY14B102N software STORE cycle is initiated by executing sequential  $\overline{CE}$  controlled read cycles from six specific address locations in exact order. During the STORE cycle an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, further input and output are disabled until the cycle is completed.

Because a sequence of READs from specific addresses is used for STORE initiation, it is important that no other read or write accesses intervene in the sequence, or the sequence is aborted and no STORE or RECALL takes place.

To initiate the software STORE cycle, the following read sequence must be performed.

1. Read Address 0x4E38 Valid READ
2. Read Address 0xB1C7 Valid READ
3. Read Address 0x83E0 Valid READ
4. Read Address 0x7C1F Valid READ
5. Read Address 0x703F Valid READ
6. Read Address 0x8FC0 Initiate STORE Cycle

**Table 1. Mode Selection**

$\overline{CE}$	$\overline{WE}$	$\overline{OE}, \overline{BHE}, \overline{BLE}^{[3]}$	$A_{15} - A_0^{[8]}$	Mode	IO	Power
H	X	X	X	Not Selected	Output High Z	Standby
L	H	L	X	Read SRAM	Output Data	Active
L	L	X	X	Write SRAM	Input Data	Active
L	H	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8B45	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Disable	Output Data Output Data Output Data Output Data Output Data Output Data	Active <sup>[9, 10]</sup>

The software sequence may be clocked with  $\overline{CE}$  controlled reads or OE controlled reads. After the sixth address in the sequence is entered, the STORE cycle commences and the chip is disabled. HSB will be driven LOW. It is important to use read cycles and not write cycles in the sequence, although it is not necessary that OE be LOW for a valid sequence. After the  $t_{STORE}$  cycle time is fulfilled, the SRAM is activated again for the read and write operation.

**Software RECALL**

Transfer the data from the nonvolatile memory to the SRAM with a software address sequence. A software RECALL cycle is initiated with a sequence of read operations in a manner similar to the software STORE initiation. To initiate the RECALL cycle, the following sequence of  $\overline{CE}$  controlled read operations must be performed.

1. Read Address 0x4E38 Valid READ
2. Read Address 0xB1C7 Valid READ
3. Read Address 0x83E0 Valid READ
4. Read Address 0x7C1F Valid READ
5. Read Address 0x703F Valid READ
6. Read Address 0x4C63 Initiate RECALL Cycle

Internally, RECALL is a two step procedure. First, the SRAM data is cleared; then, the nonvolatile information is transferred into the SRAM cells. After the  $t_{RECALL}$  cycle time, the SRAM is again ready for read and write operations. The RECALL operation does not alter the data in the nonvolatile elements.

**Notes**

8. While there are 18 address lines on the CY14B102L (17 address lines on the CY14B102N), only the 13 address lines ( $A_{14} - A_2$ ) are used to control software modes. Rest of the address lines are don't care.
9. The six consecutive address locations must be in the order listed.  $\overline{WE}$  must be HIGH during all six cycles to enable a nonvolatile cycle.
10. IO state depends on the state of OE, BHE, and BLE. The IO table shown assumes OE, BHE, and BLE LOW.

**Table 1. Mode Selection** (continued)

$\overline{CE}$	$\overline{WE}$	$\overline{OE}, \overline{BHE}, \overline{BLE}^{[3]}$	$A_{15} - A_0^{[8]}$	Mode	IO	Power
L	H	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4B46	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Enable	Output Data Output Data Output Data Output Data Output Data Output Data	Active <sup>[9, 10]</sup>
L	H	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8FC0	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile Store	Output Data Output Data Output Data Output Data Output Data Output High Z	Active $I_{CC2}^{[9, 10]}$
L	H	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4C63	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile Recall	Output Data Output Data Output Data Output Data Output Data Output High Z	Active <sup>[9, 10]</sup>

### Preventing AutoStore

The AutoStore function is disabled by initiating an AutoStore disable sequence. A sequence of read operations is performed in a manner similar to the software STORE initiation. To initiate the AutoStore disable sequence, the following sequence of CE controlled read operations must be performed:

1. Read address 0x4E38 Valid READ
2. Read address 0xB1C7 Valid READ
3. Read address 0x83E0 Valid READ
4. Read address 0x7C1F Valid READ
5. Read address 0x703F Valid READ
6. Read address 0x8B45 AutoStore Disable

The AutoStore is re-enabled by initiating an AutoStore enable sequence. A sequence of read operations is performed in a manner similar to the software RECALL initiation. To initiate the AutoStore enable sequence, the following sequence of CE controlled read operations must be performed:

1. Read address 0x4E38 Valid READ
2. Read address 0xB1C7 Valid READ
3. Read address 0x83E0 Valid READ
4. Read address 0x7C1F Valid READ
5. Read address 0x703F Valid READ
6. Read address 0x4B46 AutoStore Enable

If the AutoStore function is disabled or re-enabled, a manual STORE operation (hardware or software) must be issued to save the AutoStore state through subsequent power down cycles. The part comes from the factory with AutoStore enabled.

### Data Protection

The CY14B102L/CY14B102N protects data from corruption during low voltage conditions by inhibiting all externally initiated STORE and write operations. The low voltage condition is detected when  $V_{CC} < V_{SWITCH}$ . If the CY14B102L/CY14B102N is in a write mode (both CE and WE are LOW) at power up, after a RECALL or STORE, the write is inhibited until the SRAM is enabled after  $t_{LZHSB}$  (HSB to output active). This protects against inadvertent writes during power up or brown out conditions.

### Noise Considerations

Refer to CY application note [AN1064](#).

**Maximum Ratings**

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

- Storage Temperature ..... -65°C to +150°C
- Maximum Accumulated Storage Time
  - .....At 150°C Ambient Temperature..... 1000h
  - .....At 85°C Ambient Temperature..... 20 Years
- Ambient Temperature with Power Applied ..... -55°C to +150°C
- Supply Voltage on V<sub>CC</sub> Relative to GND ..... -0.5V to 4.1V
- Voltage Applied to Outputs in High-Z State ..... -0.5V to V<sub>CC</sub> + 0.5V
- Input Voltage ..... -0.5V to V<sub>CC</sub> + 0.5V
- Transient Voltage (<20 ns) on Any Pin to Ground Potential ..... -2.0V to V<sub>CC</sub> + 2.0V

- Package Power Dissipation Capability (T<sub>A</sub> = 25°C) ..... 1.0W
- Surface Mount Pb Soldering Temperature (3 Seconds) ..... +260°C
- DC Output Current (1 output at a time, 1s duration).... 15 mA
- Static Discharge Voltage..... > 2001V (per MIL-STD-883, Method 3015)
- Latch Up Current ..... > 200 mA

**Operating Range**

Range	Ambient Temperature	V <sub>CC</sub>
Commercial	0°C to +70°C	2.7V to 3.6V
Industrial	-40°C to +85°C	2.7V to 3.6V
Automotive	-40°C to +125°C	2.7V to 3.6V

**DC Electrical Characteristics**

Over the Operating Range (V<sub>CC</sub> = 2.7V to 3.6V)

Parameter	Description	Test Conditions	Min	Max	Unit
I <sub>CC1</sub>	Average V <sub>CC</sub> Current	t <sub>RC</sub> = 20 ns	Commercial	65	mA
		t <sub>RC</sub> = 25 ns		65	mA
		t <sub>RC</sub> = 45 ns		50	mA
		Values obtained without output loads (I <sub>OUT</sub> = 0 mA)	Industrial	70	mA
				70	mA
				52	mA
		t <sub>RC</sub> = 25 ns	Automotive	90	mA
		t <sub>RC</sub> = 45 ns		75	mA
		Values obtained without output loads (I <sub>OUT</sub> = 0 mA)			
I <sub>CC2</sub>	Average V <sub>CC</sub> Current during STORE	All Inputs Don't Care, V <sub>CC</sub> = Max Average current for duration t <sub>STORE</sub>		10	mA
I <sub>CC3</sub> <sup>[11]</sup>	Average V <sub>CC</sub> Current at t <sub>RC</sub> = 200 ns, 3V, 25°C typical	All I/P cycling at CMOS levels. Values obtained without output loads (I <sub>OUT</sub> = 0 mA).		35	mA
I <sub>CC4</sub>	Average V <sub>CAP</sub> Current during AutoStore Cycle	All Inputs Don't Care, V <sub>CC</sub> = Max Average current for duration t <sub>STORE</sub>		5	mA
I <sub>SB</sub>	V <sub>CC</sub> Standby Current	CE ≥ (V <sub>CC</sub> - 0.2). All others V <sub>IN</sub> ≤ 0.2V or ≥ (V <sub>CC</sub> - 0.2V). Standby current level after nonvolatile cycle is complete. Inputs are static. f = 0 MHz.		5	mA
I <sub>IX</sub> <sup>[12]</sup>	Input Leakage Current (except HSB)	V <sub>CC</sub> = Max, V <sub>SS</sub> ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>	-1	+1	μA
	Input Leakage Current (for HSB)	V <sub>CC</sub> = Max, V <sub>SS</sub> ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>	-100	+1	μA
I <sub>OZ</sub>	Off-State Output Leakage Current	V <sub>CC</sub> = Max, V <sub>SS</sub> ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub> . CE or OE ≥ V <sub>IH</sub> or BHE/BLE ≥ V <sub>IH</sub> or WE ≤ V <sub>IL</sub>	-1	+1	μA
V <sub>IH</sub>	Input HIGH Voltage		2.0	V <sub>CC</sub> + 0.5	V
V <sub>IL</sub>	Input LOW Voltage		V <sub>SS</sub> - 0.5	0.8	V
V <sub>OH</sub>	Output HIGH Voltage	I <sub>OUT</sub> = -2 mA	2.4		V
V <sub>OL</sub>	Output LOW Voltage	I <sub>OUT</sub> = 4 mA		0.4	V
V <sub>CAP</sub> <sup>[13]</sup>	Storage Capacitor	Between V <sub>CAP</sub> pin and V <sub>SS</sub> , 5V Rated	61	180	μF

**Notes**

11. Typical conditions for the active current shown on the DC Electrical characteristics are average values at 25°C (room temperature), and V<sub>CC</sub> = 3V. Not 100% tested.
12. The HSB pin has I<sub>OUT</sub> = -2 μA for V<sub>OH</sub> of 2.4V when both active HIGH and LOW drivers are disabled. When they are enabled standard V<sub>OH</sub> and V<sub>OL</sub> are valid. This parameter is characterized but not tested.
13. V<sub>CAP</sub> (Storage capacitor) nominal value is 68μF.

**Data Retention and Endurance**

Parameter	Description	Min	Unit
DATA <sub>R</sub>	Data Retention	20	Years
NV <sub>C</sub>	Nonvolatile STORE Operations	200	K

**Capacitance**

In the following table, the capacitance parameters are listed.<sup>[14]</sup>

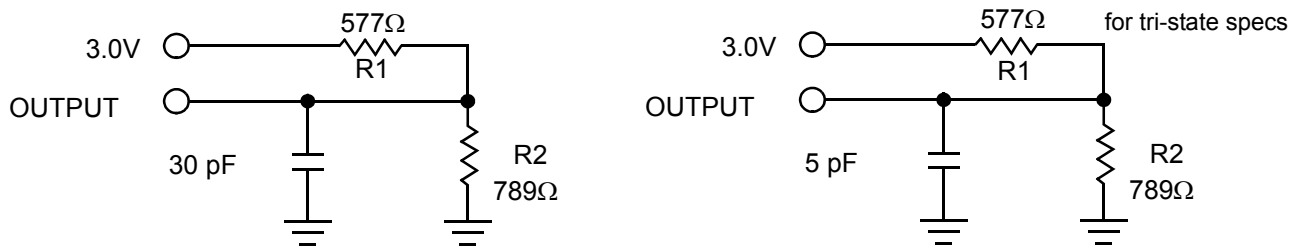
Parameter	Description	Test Conditions	Max	Unit
C <sub>IN</sub>	Input Capacitance	T <sub>A</sub> = 25°C, f = 1 MHz, V <sub>CC</sub> = 0 to 3.0V	7	pF
C <sub>OUT</sub>	Output Capacitance		7	pF

**Thermal Resistance**

In the following table, the thermal resistance parameters are listed. <sup>[14]</sup>

Parameter	Description	Test Conditions	48-FBGA	44-TSOP II	54-TSOP II	Unit
Θ <sub>JA</sub>	Thermal Resistance (Junction to Ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, in accordance with EIA/JESD51.	28.82	31.11	30.73	°C/W
Θ <sub>JC</sub>	Thermal Resistance (Junction to Case)		7.84	5.56	6.08	°C/W

**Figure 5. AC Test Loads**



**AC Test Conditions**

Input Pulse Levels..... 0V to 3V  
 Input Rise and Fall Times (10% - 90%)..... ≤3 ns  
 Input and Output Timing Reference Levels..... 1.5V

**Note**  
 14. These parameters are guaranteed but not tested.

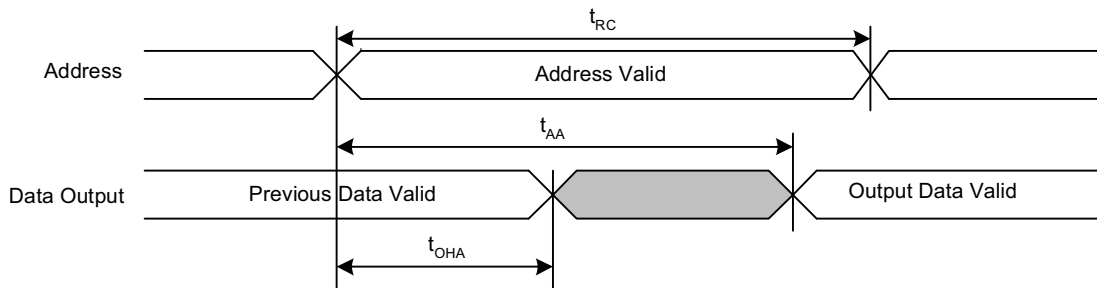


**AC Switching Characteristics**

Parameters		Description	20 ns		25 ns		45 ns		Unit
Cypress Parameters	Alt Parameters		Min	Max	Min	Max	Min	Max	
<b>SRAM Read Cycle</b>									
$t_{ACE}$	$t_{ACS}$	Chip Enable Access Time		20		25		45	ns
$t_{RC}^{[15]}$	$t_{RC}$	Read Cycle Time	20		25		45		ns
$t_{AA}^{[16]}$	$t_{AA}$	Address Access Time		20		25		45	ns
$t_{DOE}$	$t_{OE}$	Output Enable to Data Valid		10		12		20	ns
$t_{OHA}^{[16]}$	$t_{OH}$	Output Hold After Address Change	3		3		3		ns
$t_{LZCE}^{[17]}$	$t_{LZ}$	Chip Enable to Output Active	3		3		3		ns
$t_{HZCE}^{[17]}$	$t_{HZ}$	Chip Disable to Output Inactive		8		10		15	ns
$t_{LZOE}^{[17]}$	$t_{OLZ}$	Output Enable to Output Active	0		0		0		ns
$t_{HZOE}^{[17]}$	$t_{OHZ}$	Output Disable to Output Inactive		8		10		15	ns
$t_{PU}^{[14]}$	$t_{PA}$	Chip Enable to Power Active	0		0		0		ns
$t_{PD}^{[14]}$	$t_{PS}$	Chip Disable to Power Standby		20		25		45	ns
$t_{DBE}$	-	Byte Enable to Data Valid		10		12		20	ns
$t_{LZBE}$	-	Byte Enable to Output Active	0		0		0		ns
$t_{HZBE}$	-	Byte Disable to Output Inactive		8		10		15	ns
<b>SRAM Write Cycle</b>									
$t_{WC}$	$t_{WC}$	Write Cycle Time	20		25		45		ns
$t_{PWE}$	$t_{WP}$	Write Pulse Width	15		20		30		ns
$t_{SCE}$	$t_{CW}$	Chip Enable To End of Write	15		20		30		ns
$t_{SD}$	$t_{DW}$	Data Setup to End of Write	8		10		15		ns
$t_{HD}$	$t_{DH}$	Data Hold After End of Write	0		0		0		ns
$t_{AW}$	$t_{AW}$	Address Setup to End of Write	15		20		30		ns
$t_{SA}$	$t_{AS}$	Address Setup to Start of Write	0		0		0		ns
$t_{HA}$	$t_{WR}$	Address Hold After End of Write	0		0		0		ns
$t_{HZWE}^{[17,18]}$	$t_{WZ}$	Write Enable to Output Disable		8		10		15	ns
$t_{LZWE}^{[17]}$	$t_{OW}$	Output Active after End of Write	3		3		3		ns
$t_{BW}$	-	Byte Enable to End of Write	15		20		30		ns

**Switching Waveforms**

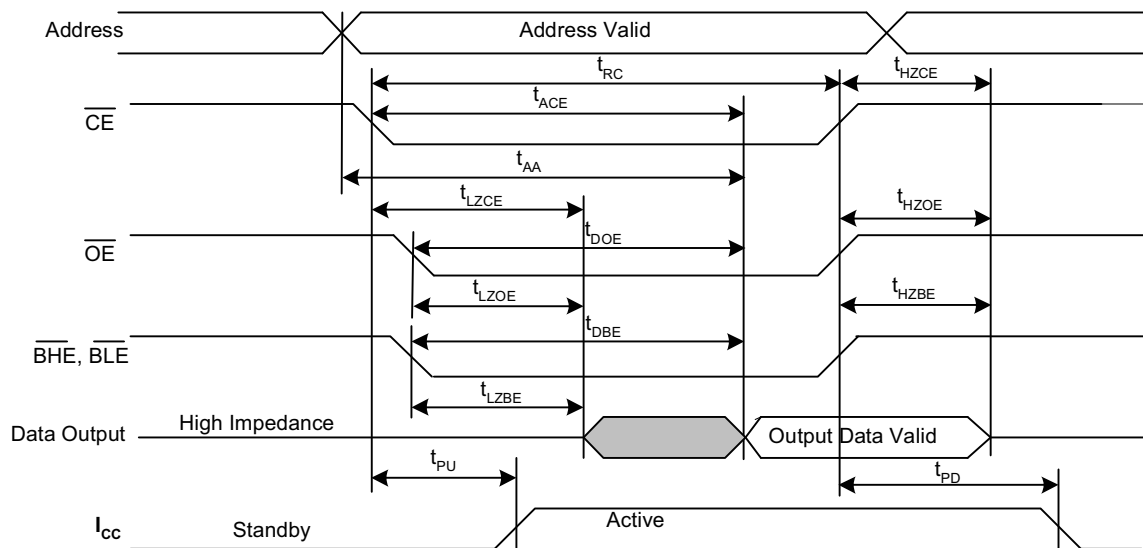
**Figure 6. SRAM Read Cycle #1: Address Controlled<sup>[15, 16, 19]</sup>**



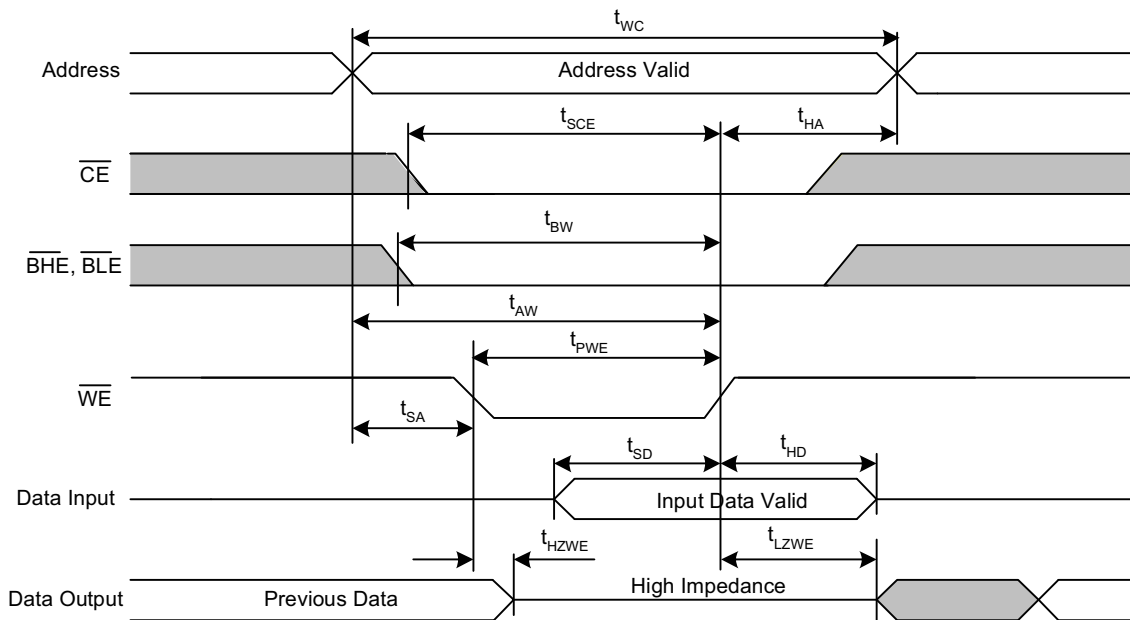
**Notes**

- 15. WE must be HIGH during SRAM read cycles.
- 16. Device is continuously selected with CE, OE and BHE / BLE LOW.
- 17. Measured ±200 mV from steady state output voltage.
- 18. If WE is LOW when CE goes LOW, the outputs remain in the high impedance state.
- 19. HSB must remain HIGH during READ and WRITE cycles.

**Figure 7. SRAM Read Cycle #2:  $\overline{\text{CE}}$  and  $\overline{\text{OE}}$  Controlled<sup>[3, 15, 19]</sup>**

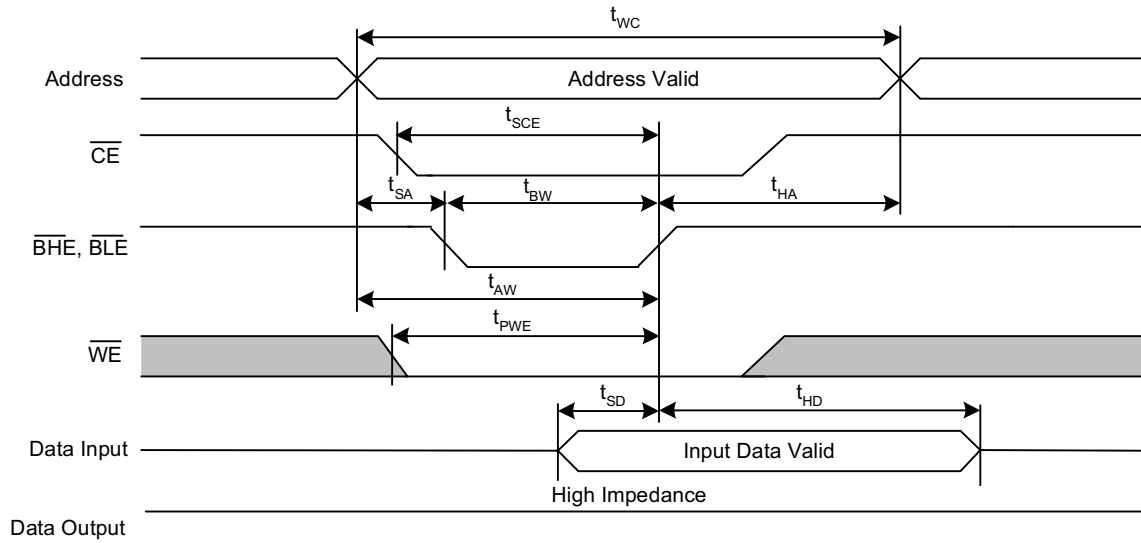


**Figure 8. SRAM Write Cycle #1:  $\overline{\text{WE}}$  Controlled<sup>[3, 18, 19, 20]</sup>**

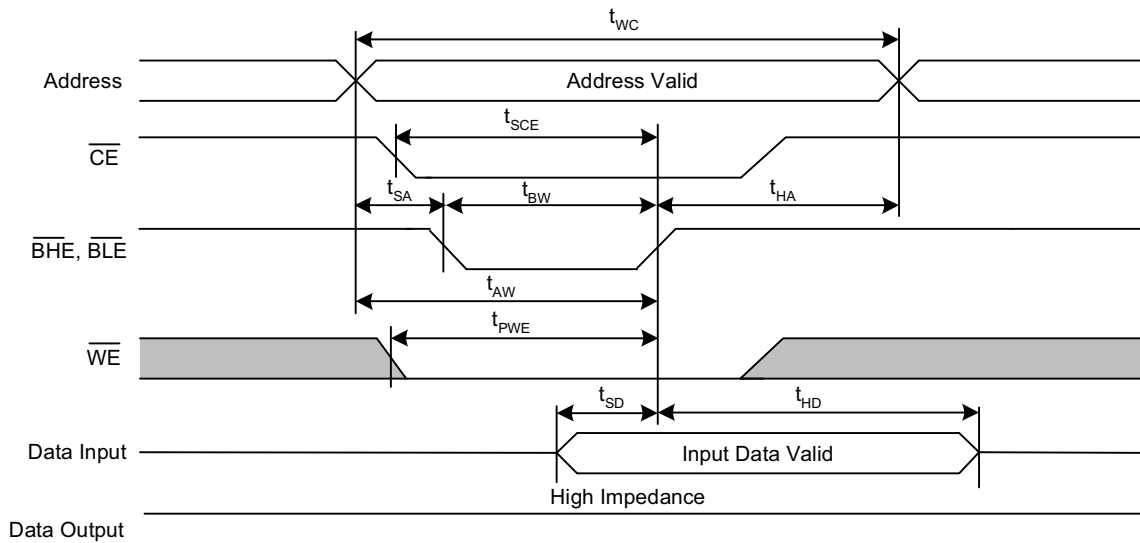


**Notes**  
20.  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$  must be  $\geq V_{\text{IH}}$  during address transitions.

**Figure 9. SRAM Write Cycle #2:  $\overline{\text{CE}}$  Controlled**<sup>[3, 18, 19, 20]</sup>



**Figure 10. SRAM Write Cycle #3:  $\overline{\text{BHE}}$  and  $\overline{\text{BLE}}$  Controlled**<sup>[3, 18, 19, 20]</sup>

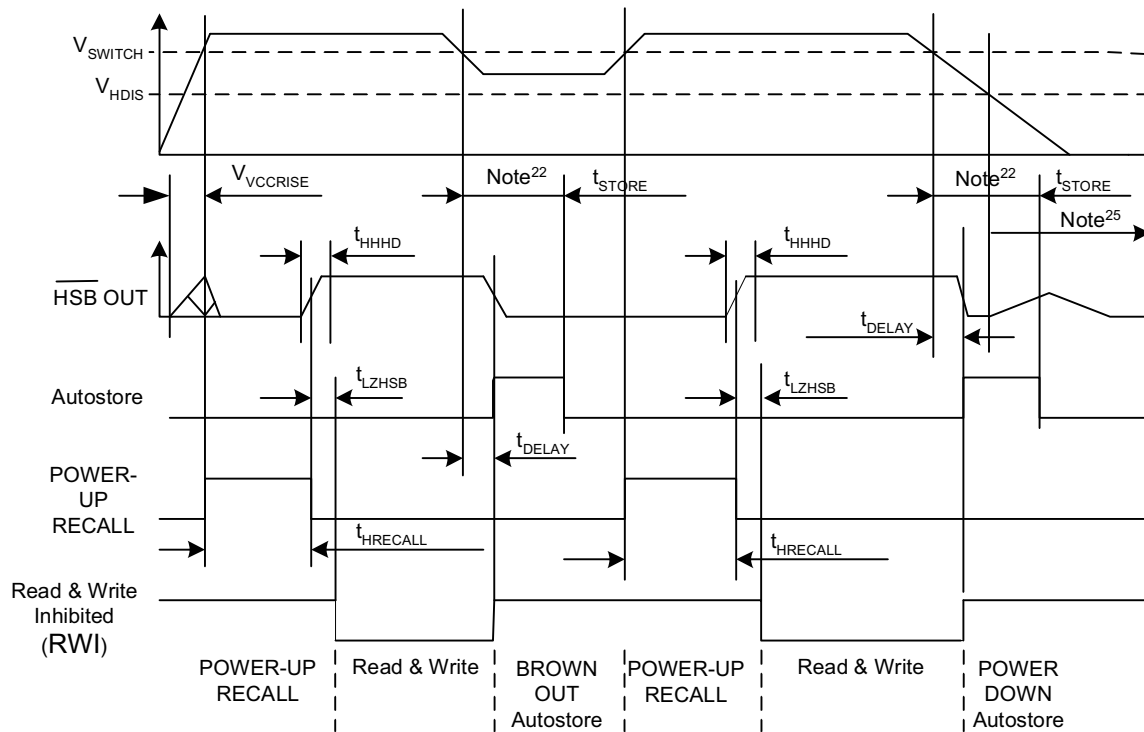


**AutoStore/Power Up RECALL**

Parameters	Description	20 ns		25 ns		45 ns		Unit
		Min	Max	Min	Max	Min	Max	
$t_{HRECALL}^{[21]}$	Power Up RECALL Duration		20		20		20	ms
$t_{STORE}^{[22]}$	STORE Cycle Duration		8		8		8	ms
$t_{DELAY}^{[23]}$	Time Allowed to Complete SRAM Cycle		20		25		25	ns
$V_{SWITCH}$	Low Voltage Trigger Level		2.65		2.65		2.65	V
$t_{VCCRRISE}$	VCC Rise Time	150		150		150		$\mu$ s
$V_{HDIS}^{[14]}$	HSB Output Driver Disable Voltage		1.9		1.9		1.9	V
$t_{LZHSB}$	HSB To Output Active Time		5		5		5	$\mu$ s
$t_{HHHD}$	HSB High Active Time		500		500		500	ns

**Switching Waveforms**

**Figure 11. AutoStore or Power Up RECALL<sup>[24]</sup>**



**Notes**

- 21.  $t_{HRECALL}$  starts from the time  $V_{CC}$  rises above  $V_{SWITCH}$ .
- 22. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware Store takes place.
- 23. On a Hardware STORE, Software Store / Recall, AutoStore Enable / Disable and AutoStore initiation, SRAM operation continues to be enabled for time  $t_{DELAY}$ .
- 24. Read and Write cycles are ignored during STORE, RECALL, and while VCC is below  $V_{SWITCH}$ .
- 25. HSB pin is driven HIGH to VCC only by internal 100kOhm resistor, HSB driver is disabled.

### Software Controlled STORE/RECALL Cycle

In the following table, the software controlled STORE/RECALL cycle parameters are listed.<sup>[26, 27]</sup>

Parameters	Description	20 ns		25 ns		45 ns		Unit
		Min	Max	Min	Max	Min	Max	
$t_{RC}$	STORE/RECALL Initiation Cycle Time	20		25		45		ns
$t_{SA}$	Address Setup Time	0		0		0		ns
$t_{CW}$	Clock Pulse Width	15		20		30		ns
$t_{HA}$	Address Hold Time	0		0		0		ns
$t_{RECALL}$	RECALL Duration		200		200		200	$\mu$ s

### Switching Waveforms

Figure 12.  $\overline{CE}$  and  $\overline{OE}$  Controlled Software STORE/RECALL Cycle<sup>[27]</sup>

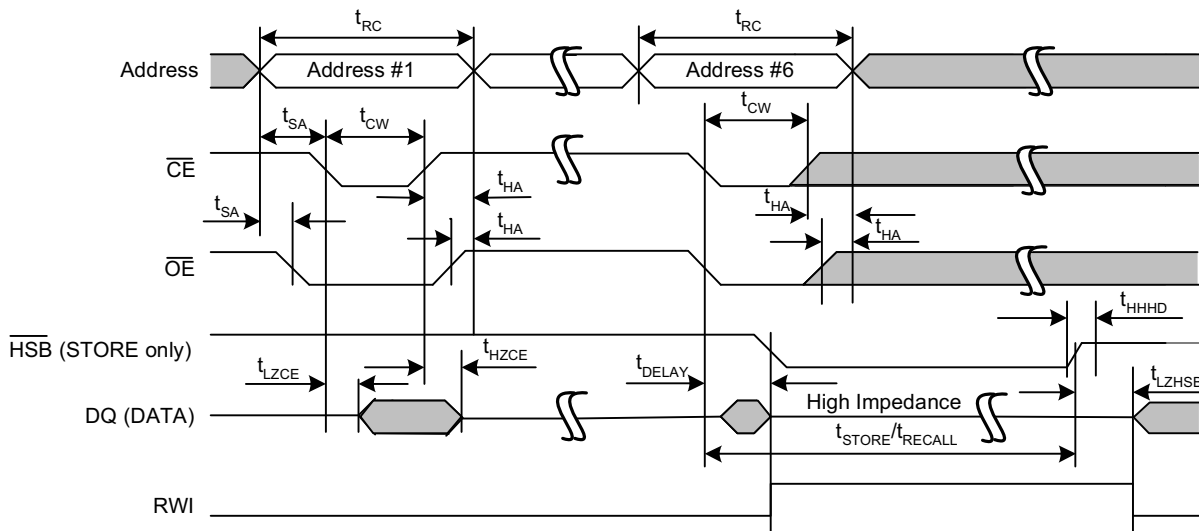
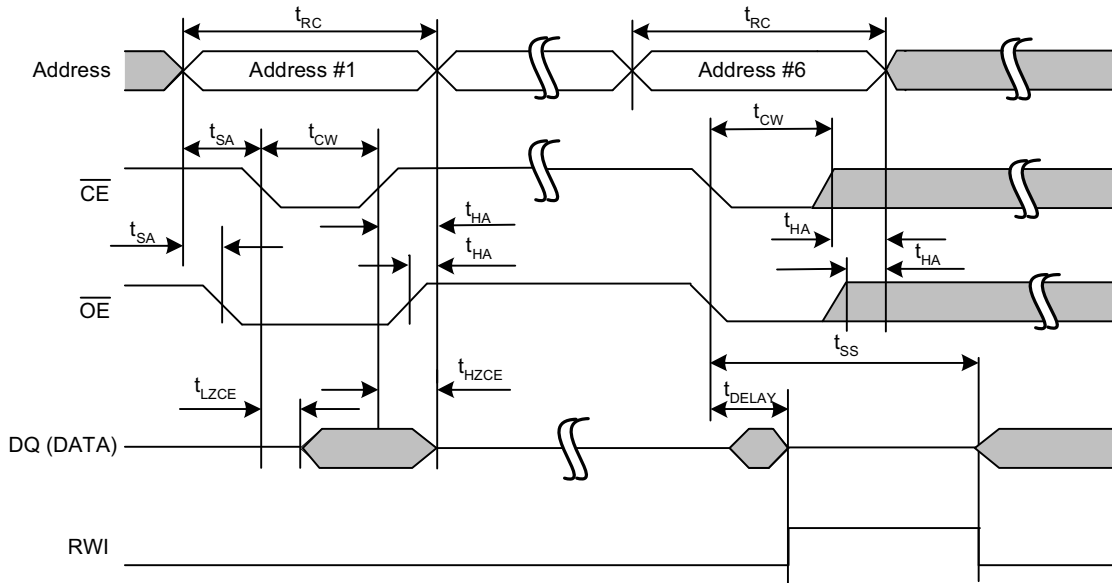


Figure 13. Autostore Enable/Disable Cycle



**Notes**

26. The software sequence is clocked with  $\overline{CE}$  controlled or  $\overline{OE}$  controlled reads.

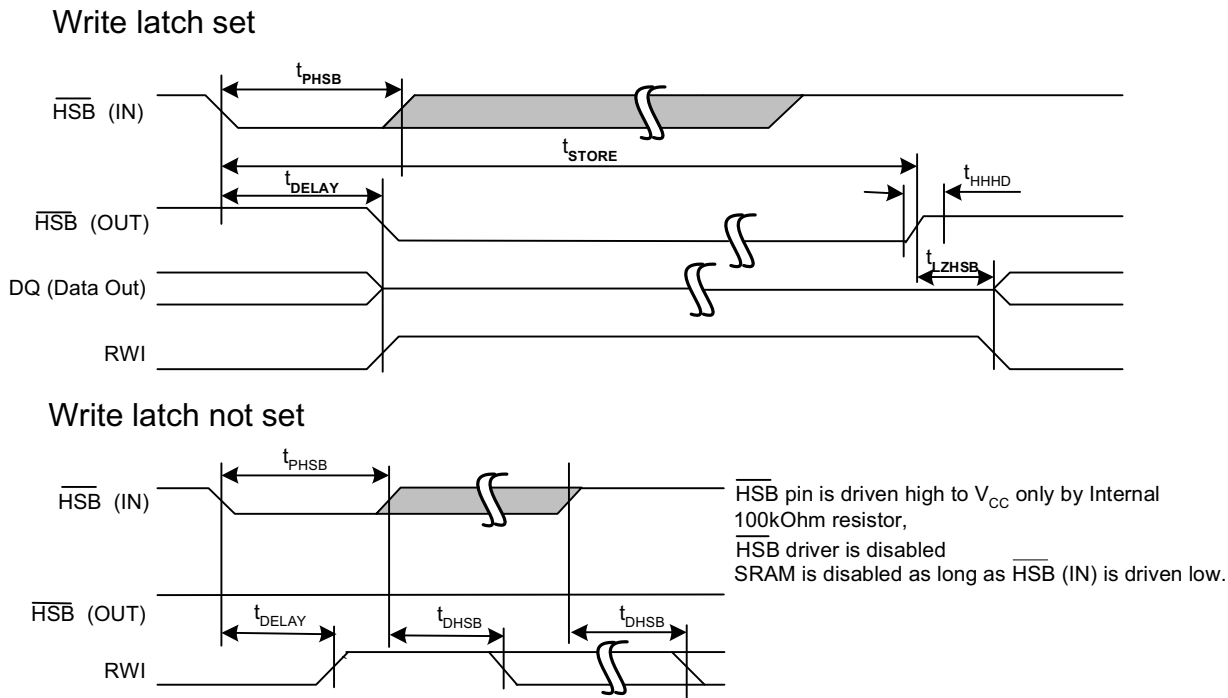
27. The six consecutive addresses must be read in the order listed in Table 1 on page 5.  $\overline{WE}$  must be HIGH during all six consecutive cycles.

**Hardware STORE Cycle**

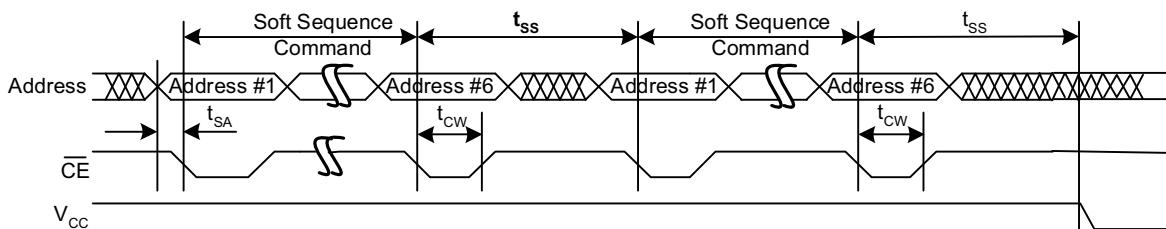
Parameters	Description	20 ns		25 ns		45 ns		Unit
		Min	Max	Min	Max	Min	Max	
$t_{DHSB}$	HSB To Output Active Time when write latch not set		20		25		25	ns
$t_{PHSB}$	Hardware STORE Pulse Width	15		15		15		ns
$t_{SS}^{[28, 29]}$	Soft Sequence Processing Time		100		100		100	$\mu$ s

**Switching Waveforms**

**Figure 14. Hardware STORE Cycle<sup>[22]</sup>**



**Figure 15. Soft Sequence Processing<sup>[28, 29]</sup>**



**Notes**

- 28. This is the amount of time it takes to take action on a soft sequence command.  $V_{CC}$  power must remain HIGH to effectively register command.
- 29. Commands such as STORE and RECALL lock out IO until operation is complete which further increases this time. See the specific command.

**Truth Table For SRAM Operations**

HSB should remain HIGH for SRAM Operations.

**For x8 Configuration**

$\overline{CE}$	$\overline{WE}$	$\overline{OE}$	Inputs/Outputs <sup>[2]</sup>	Mode	Power
H	X	X	High Z	Deselect/Power down	Standby
L	H	L	Data Out (DQ <sub>0</sub> –DQ <sub>7</sub> );	Read	Active
L	H	H	High Z	Output Disabled	Active
L	L	X	Data in (DQ <sub>0</sub> –DQ <sub>7</sub> );	Write	Active

**For x16 Configuration**

$\overline{CE}$	$\overline{WE}$	$\overline{OE}$	$\overline{BHE}$	$\overline{BLE}$	Inputs/Outputs <sup>[2]</sup>	Mode	Power
H	X	X	X	X	High-Z	Deselect/Power down	Standby
L	X	X	H	H	High-Z	Output Disabled	Active
L	H	L	L	L	Data Out (DQ <sub>0</sub> –DQ <sub>15</sub> )	Read	Active
L	H	L	H	L	Data Out (DQ <sub>0</sub> –DQ <sub>7</sub> ); DQ <sub>8</sub> –DQ <sub>15</sub> in High-Z	Read	Active
L	H	L	L	H	Data Out (DQ <sub>8</sub> –DQ <sub>15</sub> ); DQ <sub>0</sub> –DQ <sub>7</sub> in High-Z	Read	Active
L	H	H	L	L	High-Z	Output Disabled	Active
L	H	H	H	L	High-Z	Output Disabled	Active
L	H	H	L	H	High-Z	Output Disabled	Active
L	L	X	L	L	Data In (DQ <sub>0</sub> –DQ <sub>15</sub> )	Write	Active
L	L	X	H	L	Data In (DQ <sub>0</sub> –DQ <sub>7</sub> ); DQ <sub>8</sub> –DQ <sub>15</sub> in High-Z	Write	Active
L	L	X	L	H	Data In (DQ <sub>8</sub> –DQ <sub>15</sub> ); DQ <sub>0</sub> –DQ <sub>7</sub> in High-Z	Write	Active

**Ordering Information**

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
20	CY14B102L-ZS20XCT	51-85087	44-pin TSOP II	Commercial
	CY14B102L-ZS20XIT	51-85087	44-pin TSOP II	Industrial
	CY14B102L-ZS20XI	51-85087	44-pin TSOP II	
	CY14B102L-ZS20XAT	51-85087	44-pin TSOP II	Automotive
	CY14B102L-BA20XCT	51-85128	48-ball FBGA	Commercial
	CY14B102L-BA20XIT	51-85128	48-ball FBGA	Industrial
	CY14B102L-BA20XI	51-85128	48-ball FBGA	
	CY14B102L-BA20XAT	51-85128	48-ball FBGA	Automotive
	CY14B102L-ZSP20XCT	51-85160	54-pin TSOP II	Commercial
	CY14B102L-ZSP20XIT	51-85160	54-pin TSOP II	Industrial
	CY14B102L-ZSP20XI	51-85160	54-pin TSOP II	
	CY14B102L-ZSP20XAT	51-85160	54-pin TSOP II	Automotive
	CY14B102N-ZS20XCT	51-85087	44-pin TSOP II	Commercial
	CY14B102N-ZS20XIT	51-85087	44-pin TSOP II	Industrial
	CY14B102N-ZS20XI	51-85087	44-pin TSOP II	
	CY14B102N-ZS20XAT	51-85087	44-pin TSOP II	Automotive
	CY14B102N-BA20XCT	51-85128	48-ball FBGA	Commercial
	CY14B102N-BA20XIT	51-85128	48-ball FBGA	Industrial
	CY14B102N-BA20XI	51-85128	48-ball FBGA	
	CY14B102N-BA20XAT	51-85128	48-ball FBGA	Automotive
	CY14B102N-ZSP20XCT	51-85160	54-pin TSOP II	Commercial
	CY14B102N-ZSP20XIT	51-85160	54-pin TSOP II	Industrial
	CY14B102N-ZSP20XI	51-85160	54-pin TSOP II	
	CY14B102N-ZSP20XAT	51-85160	54-pin TSOP II	Automotive



**Ordering Information** (continued)

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
25	CY14B102L-ZS25XCT	51-85087	44-pin TSOP II	Commercial
	CY14B102L-ZS25XIT	51-85087	44-pin TSOP II	Industrial
	CY14B102L-ZS25XI	51-85087	44-pin TSOP II	
	CY14B102L-ZS25XAT	51-85087	44-pin TSOP II	Automotive
	CY14B102N-BA25XCT	51-85128	48-ball FBGA	Commercial
	CY14B102L-BA25XIT	51-85128	48-ball FBGA	Industrial
	CY14B102L-BA25XI	51-85128	48-ball FBGA	
	CY14B102N-BA25XAT	51-85128	48-ball FBGA	Automotive
	CY14B102L-ZSP25XCT	51-85160	54-pin TSOP II	Commercial
	CY14B102L-ZSP25XIT	51-85160	54-pin TSOP II	Industrial
	CY14B102L-ZSP25XI	51-85160	54-pin TSOP II	
	CY14B102L-ZSP25XAT	51-85160	54-pin TSOP II	Automotive
	CY14B102N-ZS25XCT	51-85087	44-pin TSOP II	Commercial
	CY14B102N-ZS25XIT	51-85087	44-pin TSOP II	Industrial
	CY14B102N-ZS25XI	51-85087	44-pin TSOP II	
	CY14B102N-ZS25XAT	51-85087	44-pin TSOP II	Automotive
	CY14B102N-BA25XCT	51-85128	48-ball FBGA	Commercial
	CY14B102N-BA25XIT	51-85128	48-ball FBGA	Industrial
	CY14B102N-BA25XI	51-85128	48-ball FBGA	
	CY14B102N-BA25XAT	51-85128	48-ball FBGA	Automotive
	CY14B102N-ZSP25XCT	51-85160	54-pin TSOP II	Commercial
	CY14B102N-ZSP25XIT	51-85160	54-pin TSOP II	Industrial
	CY14B102N-ZSP25XI	51-85160	54-pin TSOP II	
	CY14B102N-ZSP25XAT	51-85160	54-pin TSOP II	Automotive

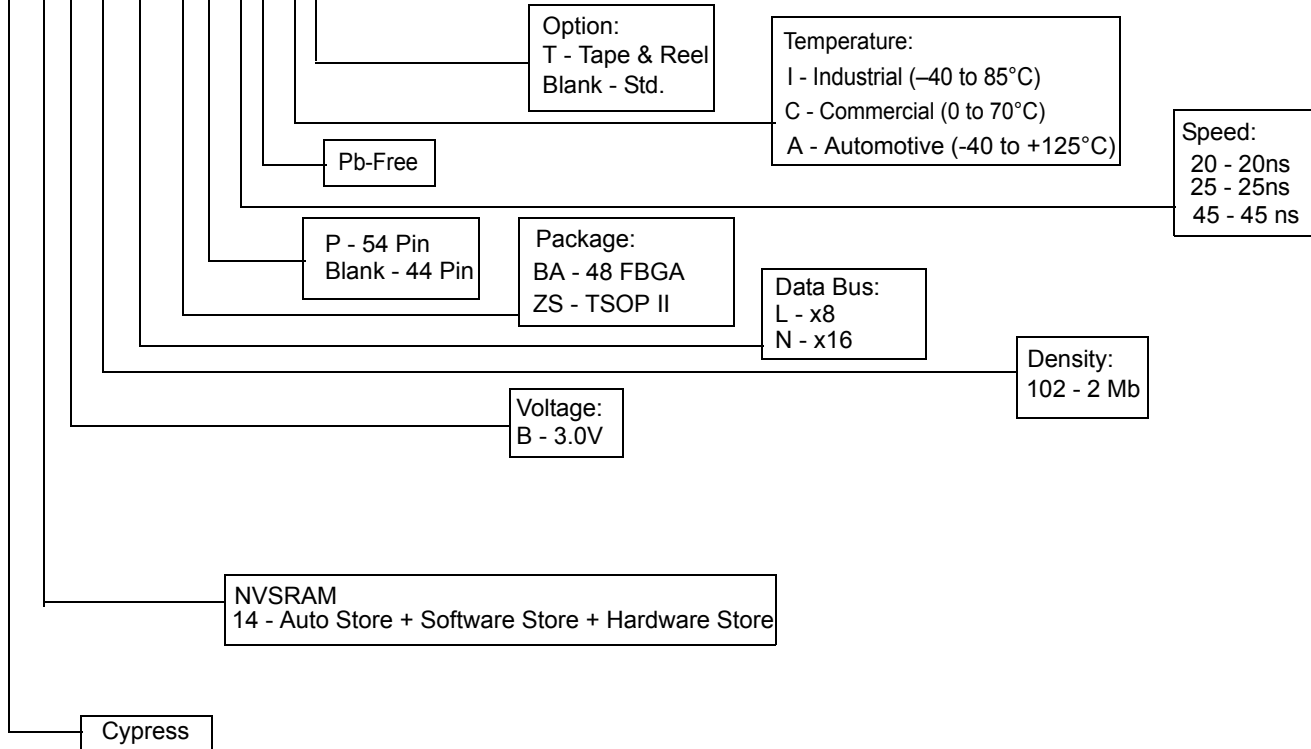
**Ordering Information** (continued)

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
45	CY14B102L-ZS45XCT	51-85087	44-pin TSOP II	Commercial
	CY14B102L-ZS45XIT	51-85087	44-pin TSOP II	Industrial
	CY14B102L-ZS45XI	51-85087	44-pin TSOP II	
	CY14B102L-ZS45XAT	51-85087	44-pin TSOP II	Automotive
	CY14B102L-BA45XCT	51-85128	48-ball FBGA	Commercial
	CY14B102L-BA45XIT	51-85128	48-ball FBGA	Industrial
	CY14B102L-BA45XI	51-85128	48-ball FBGA	
	CY14B102L-BA45XAT	51-85128	48-ball FBGA	Automotive
	CY14B102L-ZSP45XCT	51-85160	54-pin TSOP II	Commercial
	CY14B102L-ZSP45XIT	51-85160	54-pin TSOP II	Industrial
	CY14B102L-ZSP45XI	51-85160	54-pin TSOP II	
	CY14B102L-ZSP45XAT	51-85160	54-pin TSOP II	Automotive
	CY14B102N-ZS45XCT	51-85087	44-pin TSOP II	Commercial
	CY14B102N-ZS45XIT	51-85087	44-pin TSOP II	Industrial
	CY14B102N-ZS45XI	51-85087	44-pin TSOP II	
	CY14B102N-ZS45XAT	51-85087	44-pin TSOP II	Automotive
	CY14B102N-BA45XCT	51-85128	48-ball FBGA	Commercial
	CY14B102N-BA45XIT	51-85128	48-ball FBGA	Industrial
	CY14B102N-BA45XI	51-85128	48-ball FBGA	
	CY14B102N-BA45XAT	51-85128	48-ball FBGA	Automotive
	CY14B102N-ZSP45XCT	51-85160	54-pin TSOP II	Commercial
	CY14B102N-ZSP45XIT	51-85160	54-pin TSOP II	Industrial
	CY14B102N-ZSP45XI	51-85160	54-pin TSOP II	
	CY14B102N-ZSP45XAT	51-85160	54-pin TSOP II	Automotive

All parts are Pb-free. The above table contains Preliminary information. Please contact your local Cypress sales representative for availability of these parts.

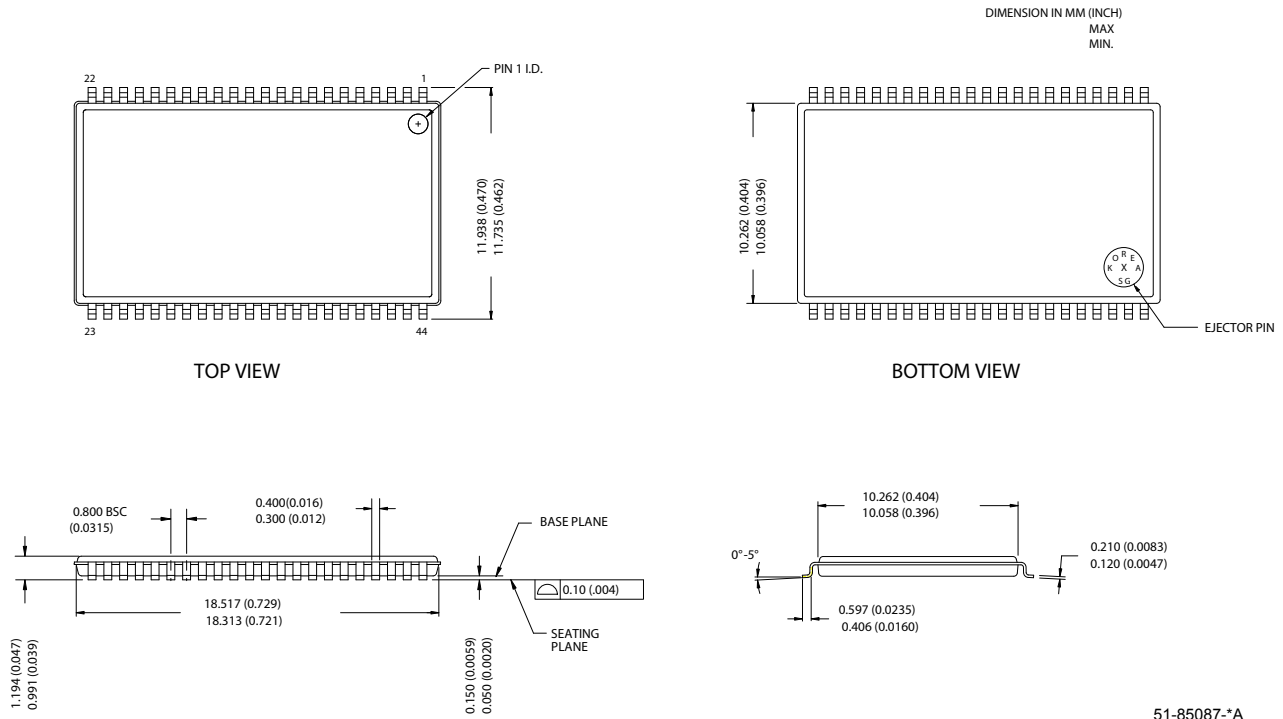
**Part Numbering Nomenclature**

**CY 14 B 102 L - ZS P 20 X C T**



**Package Diagrams**

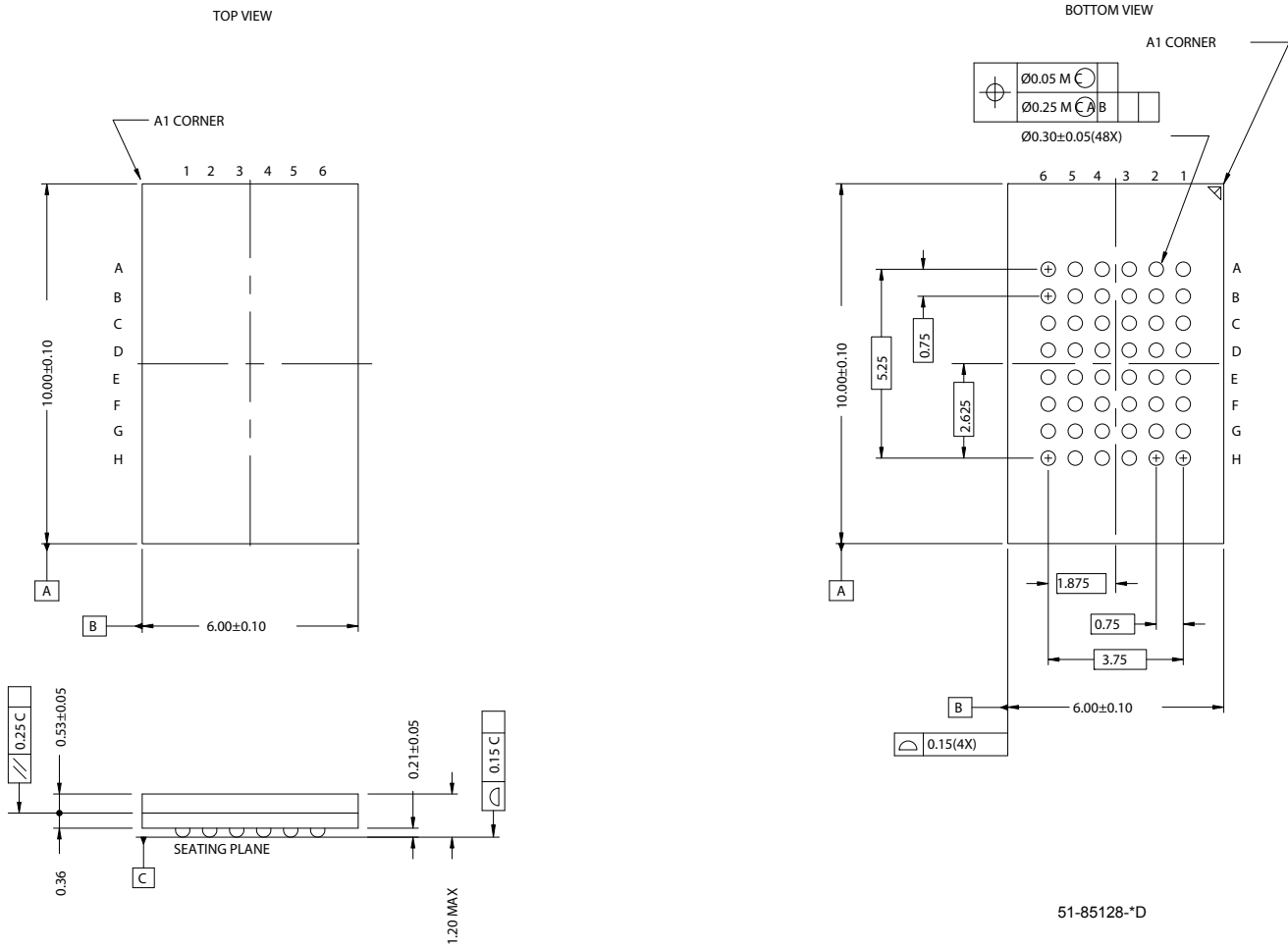
**Figure 16. 44-Pin TSOP II (51-85087)**



51-85087-\*A

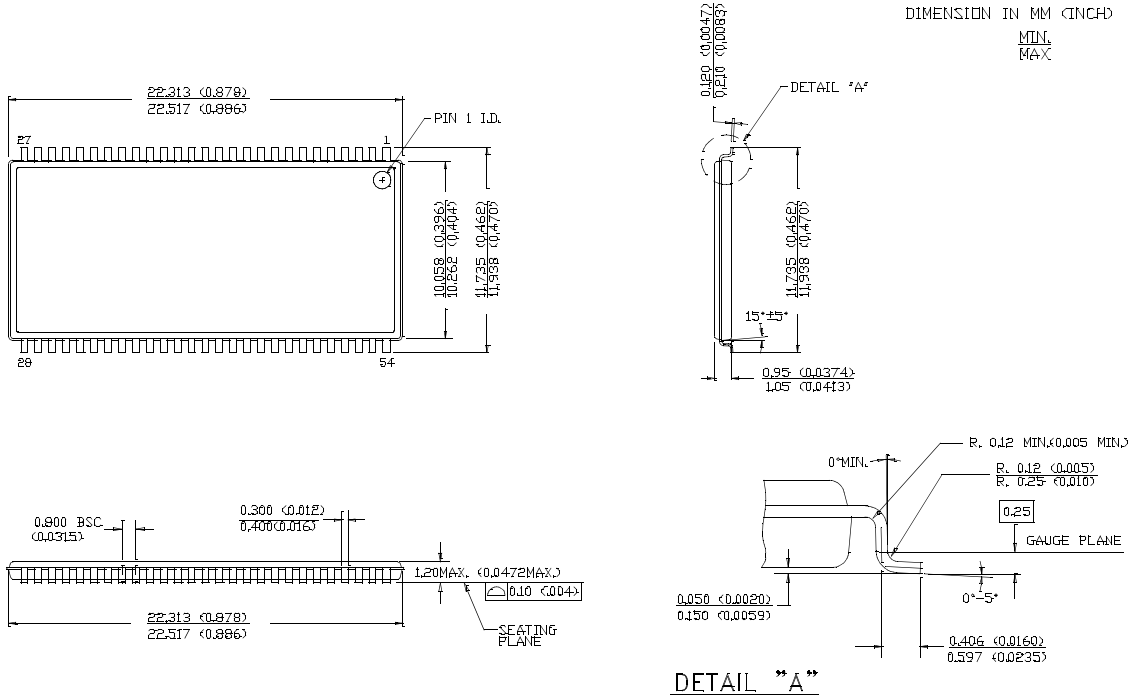
**Package Diagrams** (continued)

**Figure 17. 48-Ball FBGA - 6 mm x 10 mm x 1.2 mm (51-85128)**



**Package Diagrams** (continued)

**Figure 18. 54-Pin TSOP II (51-85160)**



51-85160-\*\*

**Document History Page**

Document Title: CY14B102L/CY14B102N 2 Mbit (256K x 8/128K x 16) nvSRAM				
Document Number: 001-45754				
Rev.	ECN No.	Submission Date	Orig. of Change	Description of Change
**	2470086	GVCH		New Data Sheet
*A	2522209	GVCH/AESA	06/27/2008	<p>Added Automotive temperature Range and 20 ns access speed information in "Features".</p> <p>Added I<sub>CC1</sub> for automotive temperature range.</p> <p>Added I<sub>CC1</sub> for t<sub>RC</sub>=20 ns for both industrial and Commercial temperature Grade.</p> <p>Updated Thermal resistance values for 48-FBGA, 44-TSOP II and 54-TSOP II Packages.</p> <p>Added AC Switching Characteristics specs for 20 ns access speed.</p> <p>Added software controlled STORE/RECALL cycle specs for 20 ns access speed.</p> <p>Updated ordering information and part numbering nomenclature.</p> <p>Updated data sheet template.</p>
*B	2606696	GVCH/PYRS	11/13/08	<p>Removed 15 ns access speed</p> <p>Updated Logic block diagram</p> <p>Updated footnote 1</p> <p>Added footnote 2 and 7</p> <p>Pin definition: Updated WE, HSB and NC pin description</p> <p>Page 4: Updated SRAM READ, SRAM WRITE, Autostore operation description</p> <p>Page 4: Updated Hardware store operation</p> <p>Page 5: Hardware RECALL (Power-up) description</p> <p>Page 6: updated Data protection description</p> <p>Maximum Ratings: Added Max. Accumulated storage time</p> <p>Changed I<sub>CC2</sub> from 6mA to 10mA</p> <p>Changed I<sub>CC4</sub> from 6mA to 5mA</p> <p>Changed I<sub>SB</sub> from 3mA to 5mA</p> <p>Updated I<sub>CC1</sub>, I<sub>CC3</sub>, I<sub>SB</sub> and I<sub>OZ</sub> Test conditions</p> <p>Changed V<sub>CAP</sub> max value from 82uF to 180uF</p> <p>Updated footnote 11 and 12</p> <p>Added footnote 13</p> <p>Added Data retention and Endurance Table</p> <p>Updated Input Rise and Fall time in AC test Conditions</p> <p>Referenced footnote 16 to t<sub>OHA</sub> parameter</p> <p>Updated All switching waveforms</p> <p>Added Figure 10 (SRAM WRITE CYCLE: BHE and BLE controlled)</p> <p>Changed t<sub>DELAY</sub> to 20ns, 25ns, 25ns for 20ns, 25ns, 45ns part respectively</p> <p>Changed t<sub>STORE</sub> from 15ms to 8ms</p> <p>Added V<sub>HDIS</sub>, t<sub>HHD</sub> and t<sub>LZHSB</sub> parameters</p> <p>Updated footnote 22 and 23</p> <p>Added footnote 25</p> <p>Software controlled STORE/RECALL cycle table: Changed t<sub>AS</sub> to t<sub>SA</sub></p> <p>Changed t<sub>GHAX</sub> to t<sub>HA</sub></p> <p>Added t<sub>DHSB</sub> parameter</p> <p>Changed t<sub>HLHX</sub> to t<sub>PHSB</sub></p> <p>Updated t<sub>SS</sub> from 70us to 100us</p> <p>Added Truth table for SRAM operations</p> <p>Updated ordering information and part numbering nomenclature</p>

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